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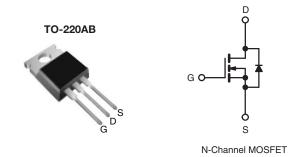






### **Power MOSFET**

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	10	100				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	0.27				
Q <sub>g</sub> (Max.) (nC)	10	16				
Q <sub>gs</sub> (nC)	4.	4.4				
Q <sub>gd</sub> (nC)	7.7					
Configuration	Single					



### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- 175 °C Operating Temperature
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF520PbF		
Lead (FD)-life	SiHF520-E3		
SnPb	IRF520		
SIFD	SiHF520		

ABSOLUTE MAXIMUM RATINGS ( $T_C$	= 25 °C, uni	ess otherwis	se notea)		_	
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	100	V	
Gate-Source Voltage			$V_{GS}$	± 20	7 v	
Continuous Drain Current	V -140V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		9.2	A	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	l <sub>D</sub>	6.5		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	37		
Linear Derating Factor				0.40	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	200	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	9.2	Α	
Repetitive Avalanche Energy <sup>a</sup>	E <sub>AR</sub>	6.0	mJ			
Maximum Power Dissipation $T_C = 25  ^{\circ}C$			$P_{D}$	60	W	
Peak Diode Recovery dV/dt <sup>c</sup>	dV/dt	5.5	V/ns			
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 <sup>d</sup>		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 3.5 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 9.2 A (see fig. 12).
- c.  $I_{SD} \le 9.2$  A,  $dI/dt \le 110$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62			
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	2.5			

PARAMETER	SYMBOL	TEST (	MIN.	TYP.	MAX.	UNIT	
Static		<u>.</u>					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0	) V, I <sub>D</sub> = 250 μA	100	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I <sub>D</sub> = 1 mA	-	0.13	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	/ <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	VG	<sub>as</sub> = ± 20 V	1	-	± 100	nA
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 1	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V		-	25	μA
Zero Gate Voltage Drain Guirent	I <sub>DSS</sub>	$V_{DS} = 80 \text{ V}, \text{ V}$	<sub>'GS</sub> = 0 V, T <sub>J</sub> = 150 °C	1	-	250	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	$I_D = 5.5 A^b$	1	-	0.27	Ω
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = 5$	50 V, I <sub>D</sub> = 5.5 A <sup>b</sup>	2.7	-	-	S
Dynamic							
Input Capacitance	$C_{iss}$	V	$V_{GS} = 0 \text{ V},$	ı	360	-	pF
Output Capacitance	C <sub>oss</sub>	V	<sub>DS</sub> = 25 V,	-	150	-	
Reverse Transfer Capacitance	$C_{rss}$	f = 1.0 MHz, see fig. 5		1	34	-	
Total Gate Charge	$Q_g$			ı	-	16	
Gate-Source Charge	$Q_{gs}$	V <sub>GS</sub> = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 9.2 \text{ A}, V_{DS} = 80 \text{ V},$		-	4.4	nC
Gate-Drain Charge	$Q_{gd}$		see fig. 6 and 13 <sup>b</sup>	-	-	7.7	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD} = 50 \text{ V}, I_D = 9.2 \text{ A},$ $R_g = 18 \ \Omega, R_D = 5.2 \ \Omega, \text{ see fig. } 10^b$ Between lead, 6 mm (0.25") from package and center of die contact		-	8.8	-	ns
Rise Time	t <sub>r</sub>			-	30	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	19	-	
Fall Time	t <sub>f</sub>			-	20	-	
Internal Drain Inductance	$L_{D}$			-	4.5	-	211
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s	·					
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	9.2	Α
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	37	
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C},  I_S = 9.2  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		i	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	- T <sub>J</sub> = 25 °C, I <sub>F</sub> = 9.2 A, dl/dt = 100 A/μs <sup>b</sup>		i	110	260	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$			-	0.53	1.3	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-	$r$ n-on is dominated by $L_S$ and $L_D$ )			L <sub>D</sub> )	

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

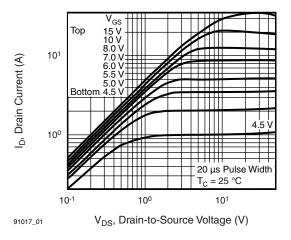


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

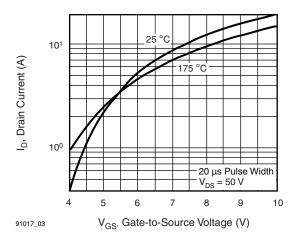


Fig. 3 - Typical Transfer Characteristics

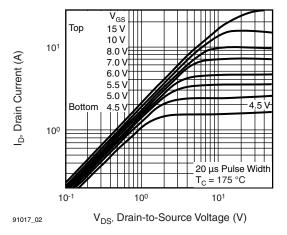


Fig. 2 - Typical Output Characteristics,  $T_C$  = 175 °C

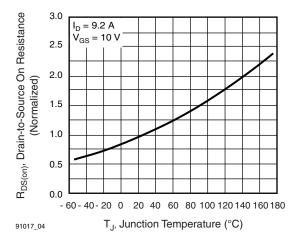
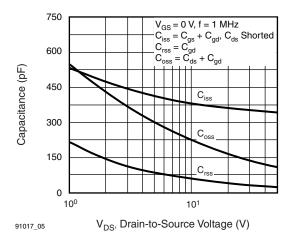


Fig. 4 - Normalized On-Resistance vs. Temperature





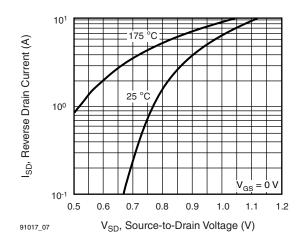


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

Fig. 7 - Typical Source-Drain Diode Forward Voltage

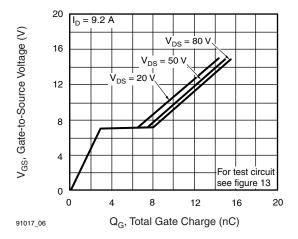


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

Fig. 8 - Maximum Safe Operating Area





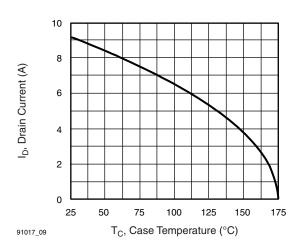


Fig. 9 - Maximum Drain Current vs. Case Temperature

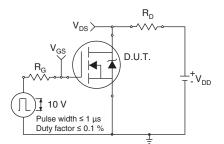


Fig. 10a - Switching Time Test Circuit

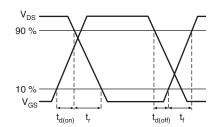


Fig. 10b - Switching Time Waveforms

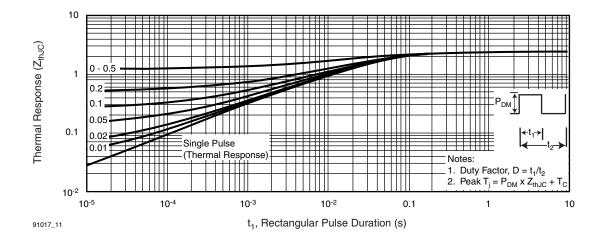


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



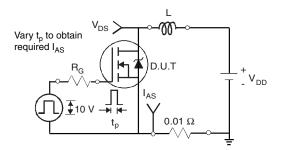


Fig. 12a - Unclamped Inductive Test Circuit

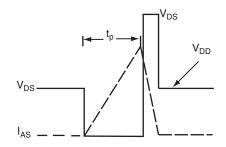


Fig. 12b - Unclamped Inductive Waveforms

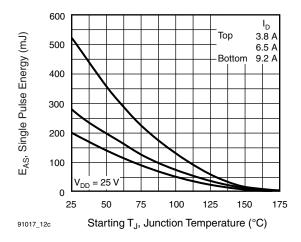


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

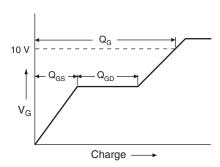


Fig. 13a - Basic Gate Charge Waveform

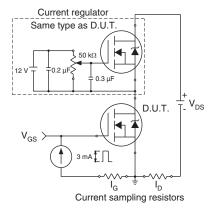
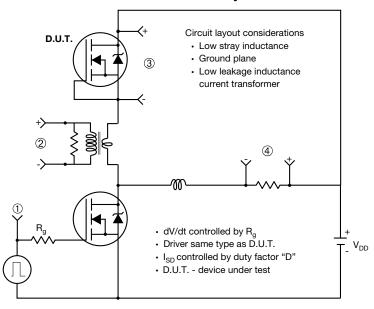


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



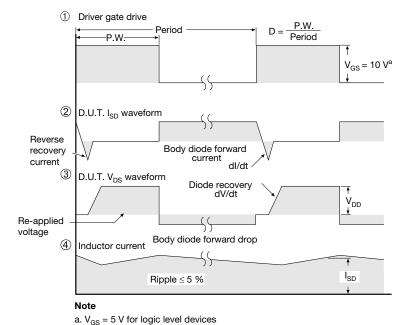


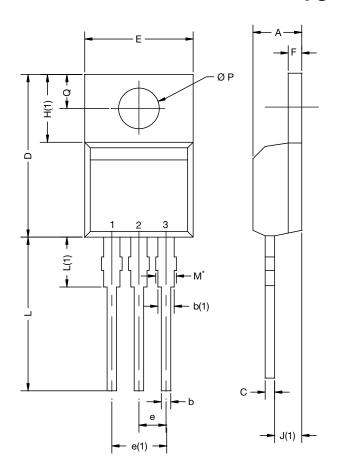
Fig. 14 - For N-Channel

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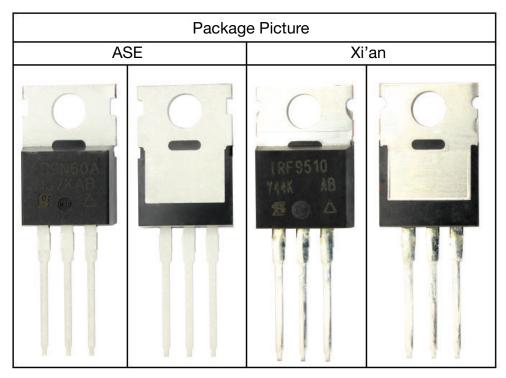
## TO-220-1



DIM.	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
Е	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

### Note

 M\* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



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